•	Se	arch	ı Not	es	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/663,165	REDDY ET AL.
Examiner	Art Unit
Huy C. Ho	2617

SEARCHED						
Subclass	Date	Examiner				
552.1	12/21/2006	нсн				
574	12/21/2006	нсн				
185	12/21/2006	нсн				
338	12/21/2006	нсн				
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	552.1 574 185	Subclass Date 552.1 12/21/2006 574 12/21/2006 185 12/21/2006 338 12/21/2006				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST image and keyword search in USPATConclusion, US-PGPUB, USOCR, EPO, JPO, DERWENT, IBM_TDB (See attached search strategy)	12/21/2006	нсн		
Ourself de Mile Lebe Barrela	40/04/0006	11013		
Consulted with John Pezzlo	12/21/2006	нсн		
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